

<b>Notice of References Cited</b>	Application/Control No. 10/750,698	Applicant(s)/Patent Under Reexamination COTTRELL ET AL.	
	Examiner Joseph F Edell	Art Unit 3636	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,347,115	09-1994	Sherman et al.	235/462.45
	B	US-5,507,556	04-1996	Dixon, Richard W.	297/217.3
	C	US-5,640,297	06-1997	Labaze, Ducarmel	361/683
	D	US-6,022,078	02-2000	Chang, Yung-Tsung	297/391
	E	US-6,669,285 B1	12-2003	Park et al.	297/217.3
	F	US-2002/0079732 A1	06-2002	Sabaran et al.	297/408
	G	US-3,019,050	01-1962	SPIELMAN JAMES F	297/217.3
	H	US-4,490,842	12-1984	Watanabe, Tatsuya	381/86
	I	US-5,779,305	07-1998	Hocking, Rory	297/217.4
	J	US-5,835,127	11-1998	Booth et al.	725/76
	K	US-2003/0234550 A1	12-2003	Brooks et al.	296/24.1
	L	US-2005/0012375 A1	01-2005	Giasson, Brigitte	297/411.31
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	DE-10247024-A1	04-2004	Germany	Donsbach, Guenter	
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.